**Type: Upgrades and Future Projects** 

## **Radiation Tolerance Tests for SFP+ Transceivers**

The results are presented for the gamma and neutron irradiation tests for SFP+ transceivers. The radiation tolerance of the electronics components used in the detector area is a key of the electronics systems at the LHC experiments. For example, the total ionising dose and the 1-MeV neutron equivalent flux estimated for the frontend electronics of the thin gap chamber of the ATLAS experiment are 14 Gy and 4 x  $10^1$  cm<sup>2</sup> for an integrated luminosity of 4000 fb<sup>1</sup>. We tested several types of SFP+ transceivers from Broadcom and Finisar. Gamma ray was irradiated up to O(100) Gy at the Cobalt-60 facility of Nagoya University. Neutrons were irradiated up to O(1012) cm<sup>2</sup> using the tandem accelerator at Kobe University. The results can be referred to in designing the systems and selecting the SFP+ transceivers for the upgrades of the LHC experiments.

Authors: WADA, Arisa (Nagoya University (JP)); OCHI, Atsuhiko (Kobe University (JP)); HASHIMOTO, Daisuke (Nagoya University (JP)); YAMASHITA, Erika (University of Tokyo (JP)); ASADA, Haruka (Nagoya University (JP)); HASHIZUME, Kazumasa (Nagoya University (JP)); TOMOTO, Makoto (High Energy Accelerator Research Organization (JP)); ISHINO, Masaya (University of Tokyo (JP)); KIKUCHI, Miyuki (Nagoya University (JP)); Mr NAGASAKA, Ren (University of Tokyo (JP)); AOKI, Takumi (University of Tokyo (JP)); HORII, Yasuyuki (Nagoya University (JP)); OKUMURA, Yasuyuki (University of Tokyo (JP)); NARUKAWA, Yoshifumi (University of Tokyo (JP)); MITSUMORI, Yuki (Nagoya University (JP)); NABEYAMA, Yuki (Nagoya University (JP)); OHSUMI, Yuya

Presenter: OHSUMI, Yuya

Session Classification: Poster session

Track Classification: Upgrades and Future Projects